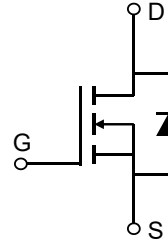


### Description

#### Features

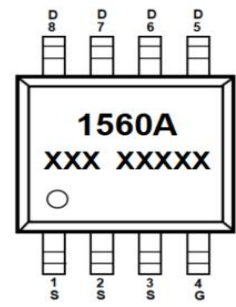
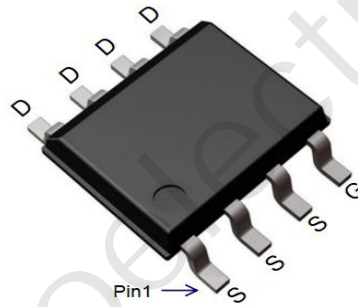
- 150V, 4.5A  
 $R_{DS(ON)}$  Typ = 61.5mΩ @  $V_{GS} = 10V$
- Advanced Split Gate Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free
- 100% UIS TESTED!



Schematic Diagram

#### Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

#### Package Marking and Ordering Information

| Device      | Marking | Package | Outline | Reel Size | Reel (pcs) | Per Carton (pcs) |
|-------------|---------|---------|---------|-----------|------------|------------------|
| CRMPGH1560A | 1560A   | SOP-8   | TAPING  | 13"       | 4000       | 40000            |

#### Absolute Maximum Ratings (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)

| Symbol          | Parameter  | Value                     | Units |
|-----------------|--|---------------------------|-------|
| $V_{DS}$        | Drain-to-Source Voltage                                | 150                       | V     |
| $V_{GS}$        | Gate-to-Source Voltage                                 | ±20                       | V     |
| $I_D$           | Continuous Drain Current                               | $T_A = 25^\circ\text{C}$  | 4.5   |
|                 |  | $T_A = 100^\circ\text{C}$ | 2.7   |
| $I_{DM}$        | Pulsed Drain Current <sup>(1)</sup>                    | 18                        | A     |
| $E_{AS}$        | Single Pulsed Avalanche Energy <sup>(2)</sup>          | 20                        | mJ    |
| $P_D$           | Power Dissipation                                      | $T_A = 25^\circ\text{C}$  | 3.1   |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient <sup>(3)</sup> | 40                        | °C/W  |
| $T_J, T_{STG}$  | Junction & Storage Temperature Range                   | -55 to 150                | °C    |

### Electrical Characteristics ( $T_J = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|------------|------|------|------|------|
|--------|-----------|------------|------|------|------|------|

#### Off Characteristics

|               |                                 |  |     |   |           |               |
|---------------|---------------------------------|--|-----|---|-----------|---------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage  | $I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$    | 150 | - | -         | V             |
| $I_{DSS}$     | Zero Gate Voltage Drain Current | $V_{DS} = 150\text{V}$ , $V_{GS} = 0\text{V}$    | -   | - | 1.0       | $\mu\text{A}$ |
| $I_{GSS}$     | Gate-Body Leakage Current       | $V_{DS} = 0\text{V}$ , $V_{GS} = \pm 20\text{V}$ | -   | - | $\pm 100$ | nA            |

#### On Characteristics

|              |  |  |     |      |     |    |
|--------------|--|--|-----|------|-----|----|
| $V_{GS(th)}$ | Gate Threshold Voltage                           | $V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$ | 2.4 | 3    | 3.6 | V  |
| $R_{DS(ON)}$ | Static Drain-Source ON-Resistance <sup>(4)</sup> | $V_{GS} = 10\text{V}$ , $I_D = 3\text{A}$  | -   | 61.5 | 80  | mΩ |

#### Dynamic Characteristics

|           |                              |   |   |     |   |    |
|-----------|------------------------------|---|---|-----|---|----|
| $C_{iss}$ | Input Capacitance            | $V_{GS} = 0\text{V}$ , $V_{DS} = 75\text{V}$ ,<br>$f = 1\text{MHz}$       | - | 368 | - | pF |
| $C_{oss}$ | Output Capacitance           |   | - | 50  | - | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |   | - | 4   | - | pF |
| $Q_g$     | Total Gate Charge            | $V_{GS} = 0$ to $10\text{V}$<br>$V_{DS} = 75\text{V}$ , $I_D = 2\text{A}$ | - | 5.5 | - | nC |
| $Q_{gs}$  | Gate Source Charge           |   | - | 1.2 | - | nC |
| $Q_{gd}$  | Gate Drain("Miller") Charge  |   | - | 2   | - | nC |

#### Switching Characteristics

|              |                    |  |   |     |   |    |
|--------------|--------------------|--|---|-----|---|----|
| $t_{d(on)}$  | Turn-On DelayTime  | $V_{GS} = 10\text{V}$ , $V_{DD} = 75\text{V}$<br>$I_D = 2\text{A}$ , $R_{GEN} = 6\Omega$ | - | 4.6 | - | ns |
| $t_r$        | Turn-On Rise Time  |  | - | 3.3 | - | ns |
| $t_{d(off)}$ | Turn-Off DelayTime |  | - | 7.5 | - | ns |
| $t_f$        | Turn-Off Fall Time |  | - | 3.6 | - | ns |

#### Drain-Source Diode Characteristics and Max Ratings

|          |  |  |   |    |     |    |
|----------|--|--|---|----|-----|----|
| $I_S$    | Maximum Continuous Drain to Source Diode Forward Current | $V_{GS} = 0\text{V}$ , $I_S = 3\text{A}$ | - | -  | 4.5 | A  |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current     |  | - | -  | 18  | A  |
| $V_{SD}$ | Drain to Source Diode Forward Voltage                    |  | - | -  | 1.2 | V  |
| $t_{rr}$ | Body Diode Reverse Recovery Time                         |  | - | 70 | -   | ns |
| $Q_{rr}$ | Body Diode Reverse Recovery Charge                       |  | - | 80 | -   | nC |

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
2.  $E_{AS}$  condition: Starting  $T_J = 25^\circ\text{C}$ ,  $V_{DD} = 50\text{V}$ ,  $V_G = 10\text{V}$ ,  $R_G = 25\Omega$ ,  $L = 0.5\text{mH}$ ,  $I_{AS} = 9\text{A}$
3.  $R_{\theta JA}$  is measured with the device mounted on a  $1\text{inch}^2$  pad of 2oz copper FR4 PCB
4. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .

## Typical Performance Characteristics

Figure 1: Output Characteristics

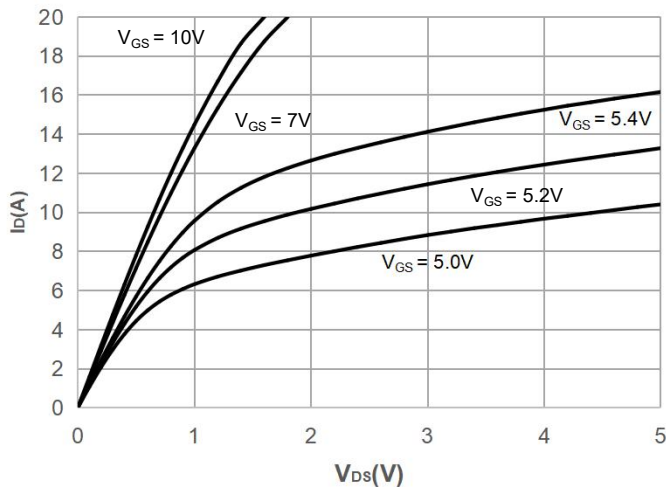


Figure 2: Typical Transfer Characteristics

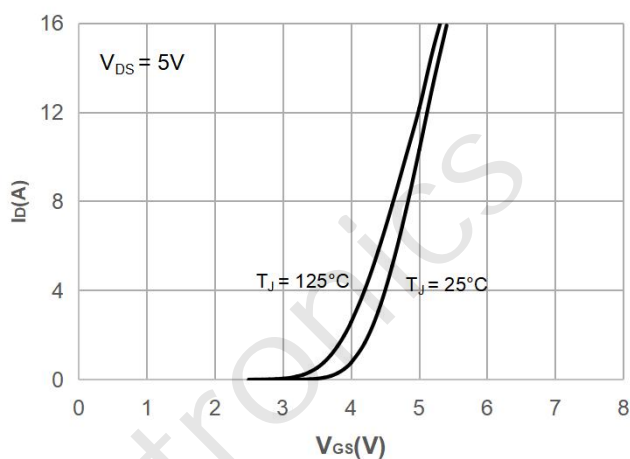


Figure 3: On-resistance vs. Drain Current

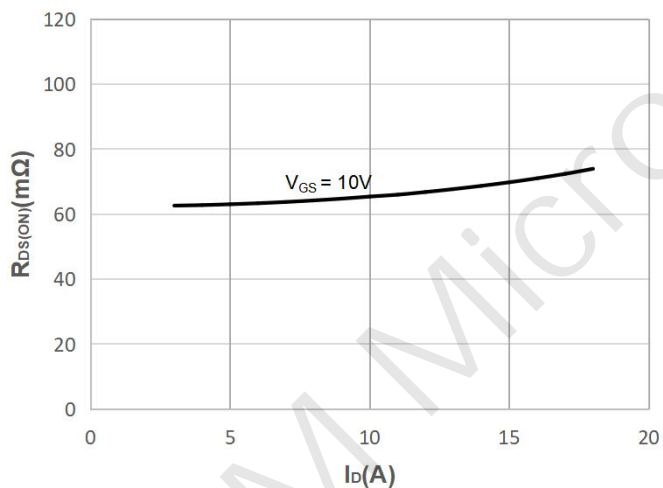


Figure 4: Body Diode Characteristics

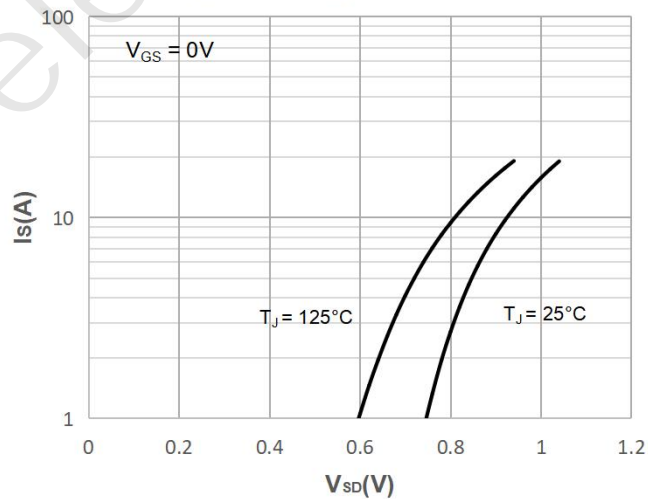


Figure 5: Gate Charge Characteristics

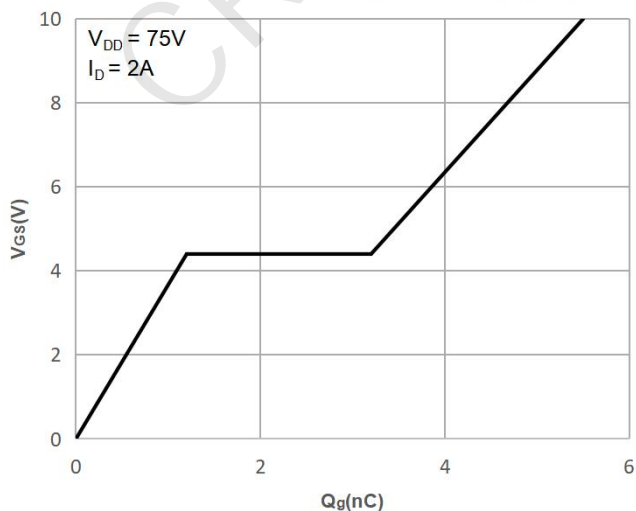
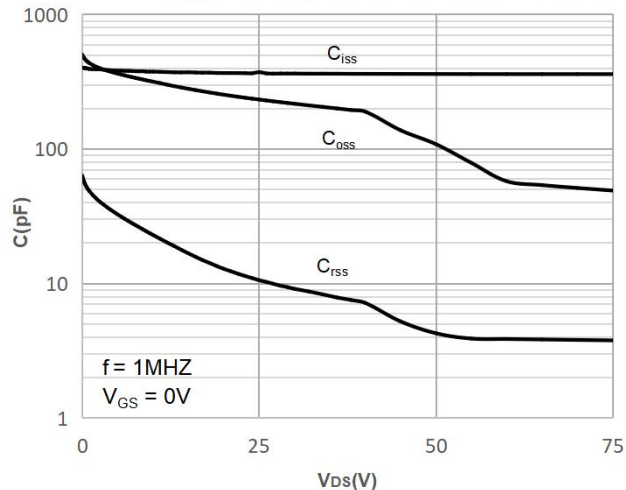


Figure 6: Capacitance Characteristics



## Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. Junction Temperature

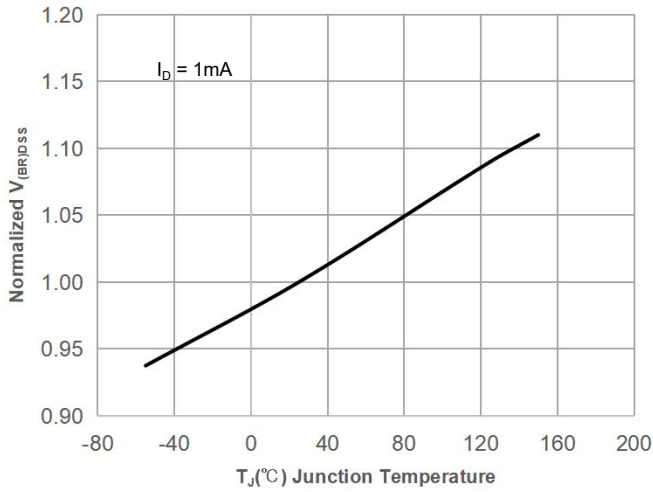


Figure 8: Normalized on Resistance vs. Junction Temperature

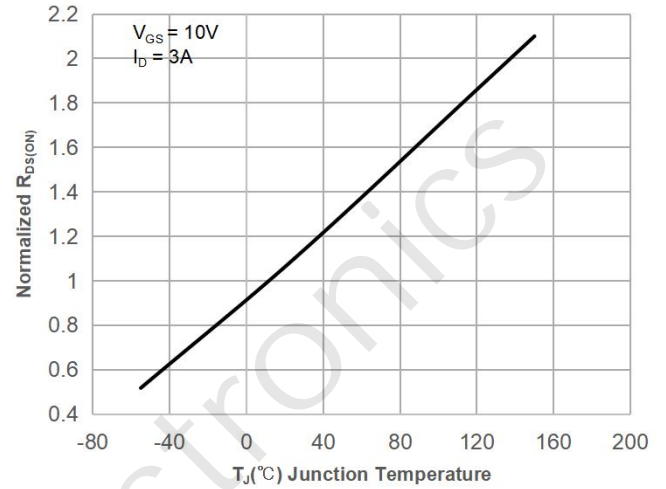


Figure 9: Maximum Safe Operating Area

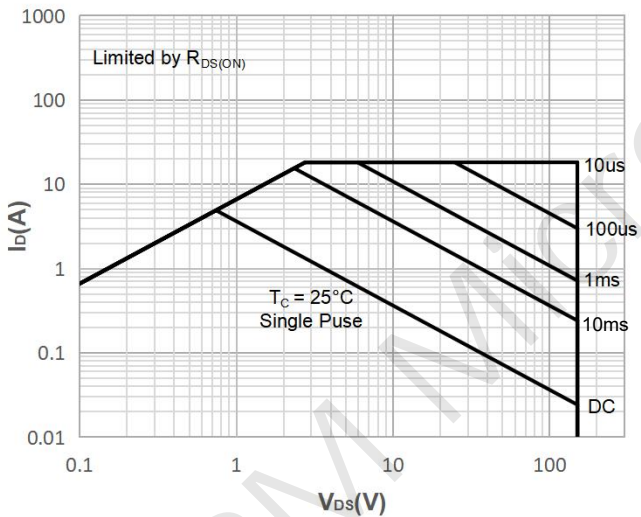


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

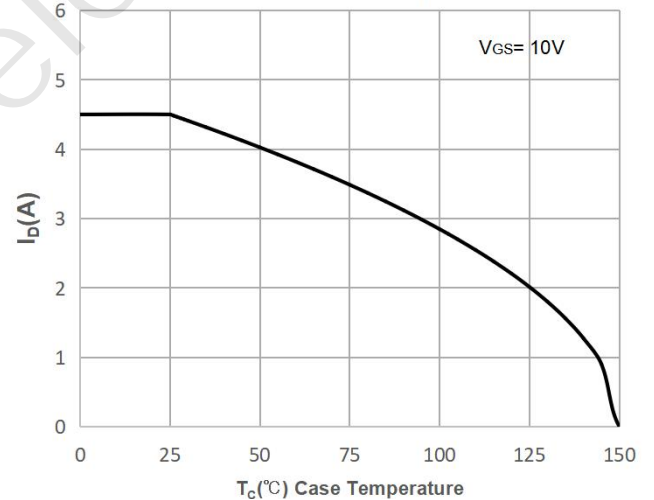


Figure 11: Normalized Maximum Transient Thermal Impedance

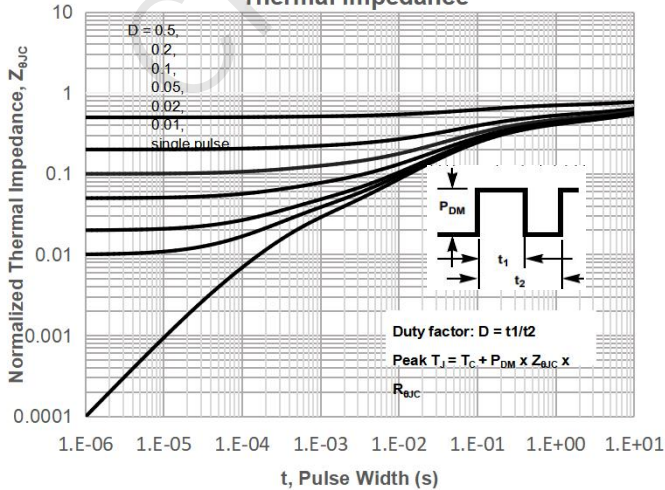
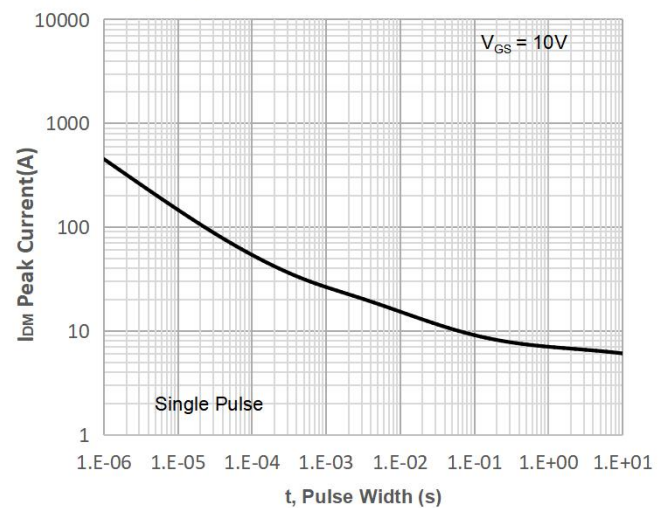


Figure 12: Peak Current Capacity



## Test Circuit



Figure 1: Gate Charge Test Circuit & Waveform



Figure 2: Resistive Switching Test Circuit & Waveform



Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

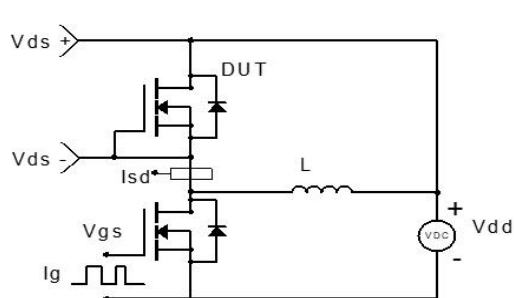
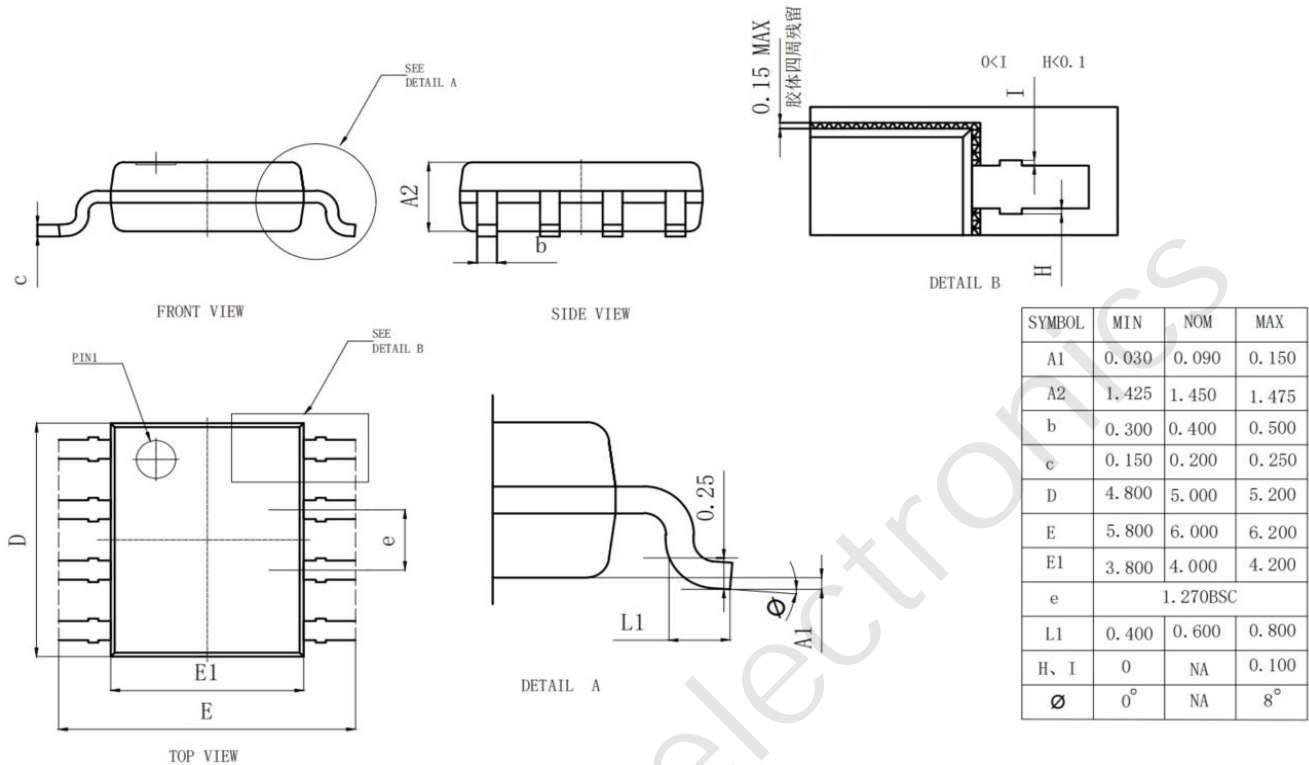


Figure 4: Diode Recovery Test Circuit & Waveform

### Package Mechanical Data(SOP-8)




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